

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/539,461	PARRUCK ET AL.	
Examiner	Art Unit	
Thien D. Tran	2665	

	SEAR	SEARCHED		
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
370	539	3/28/2006	π	
	395.52	3/28/2006	TT	
	395.51	3/28/2006	тт	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/395.51, 395.52, 465, 466, 538, 539.	3/28/2006	тт		
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